



## Vishay Semiconductors

# HEXFRED® Ultrafast Soft Recovery Diode, 80 A



SOT-227

PRODUCT SUMMARY				
V <sub>R</sub>	1200 V			
V <sub>F</sub> (typical)	2.6 V			
t <sub>rr</sub> (typical)	25 ns			
I <sub>F(DC)</sub> at T <sub>C</sub>	40 A at 78 °C			

#### **FEATURES**

- Fast recovery time characteristic
- · Electrically isolated base plate
- Large creepage distance between terminal
- Simplified mechanical designs, rapid assembly
- UL approved file E78996



- Compliant to RoHS directive 2002/95/EC
- Designed and qualified for industrial level



The dual diode series configuration (HFA80FA120P) is used for output rectification or freewheeling/clamping operation and high voltage application.

The semiconductor in the SOT-227 package is isolated from the copper base plate, allowing for common heatsinks and compact assemblies to be built.

These modules are intended for general applications such as HV power supplies, electronic welders, motor control and inverters.

ABSOLUTE MAXIMUM RATINGS				
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS
Cathode to anode voltage	V <sub>R</sub>		1200	V
Continuous forward current	I <sub>F</sub>	T <sub>C</sub> = 78 °C	40	
Single pulse forward current	I <sub>FSM</sub>	T <sub>J</sub> = 25 °C	400	Α
Maximum repetitive forward current	I <sub>FRM</sub>	Rated V <sub>R</sub> , square wave, 20 kHz, T <sub>C</sub> = 60 °C	72	
Maximum navvey dispination	В	T <sub>C</sub> = 25 °C	178 W	
Maximum power dissipation	P <sub>D</sub>	T <sub>C</sub> = 100 °C	71	VV
RMS isolation voltage	V <sub>ISOL</sub>	Any terminal to case, t = 1 min	2500	V
Operating junction and storage temperature range	T <sub>J</sub> , T <sub>Stg</sub>		- 55 to 150	°C

<b>ELECTRICAL SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNITS
Cathode to anode breakdown voltage	V <sub>BR</sub>	Ι <sub>R</sub> = 100 μΑ		1200	-	-	
Forward voltage V <sub>FM</sub>		I <sub>F</sub> = 25 A		-	2.6	3.0	V
	I <sub>F</sub> = 40 A	See fig. 1	-	2.9	3.3		
				-	3.4		-
Reverse leakage current I <sub>RM</sub>		V <sub>R</sub> = V <sub>R</sub> rated	See fig. 2	-	2.0	-	μΑ
		$T_J = 125$ °C, $V_R = 0.8 \times V_R$ rated	See lig. 2	-	0.5	2	mA
Junction capacitance	C <sub>T</sub>	V <sub>R</sub> = 200 V See fig. 3		-	43	-	pF

## Not Available for New Designs, Use VS-HFA90FA120

## HFA80FA120P

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Document Number: 94075

Revision: 22-Jul-10

<b>DYNAMIC RECOVERY CHARACTERISTICS</b> (T <sub>C</sub> = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNITS
		$I_F = 1.0 \text{ A}, dI_F/dt = 200 \text{ A/}\mu\text{s}, V_R = 30 \text{ V}$		-	25	-	
Reverse recovery time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C		-	52	-	ns
	T <sub>J</sub> = 125 °C		-	110	-		
Peak recovery current I <sub>RRM</sub>	1	T <sub>J</sub> = 25 °C	I <sub>F</sub> = 40 A dI <sub>F</sub> /dt = - 200 A/µs	-	5.9	-	А
	T <sub>J</sub> = 125 °C	$V_{R} = 200 \text{ V}$	-	10.8	-		
Reverse recovery charge Q <sub>rr</sub>	0	T <sub>J</sub> = 25 °C	·n 2001	-	160	-	nC
	Q <sub>rr</sub>	T <sub>J</sub> = 125 °C		-	630	-	IIC

THERMAL - MECHANICAL SPECIFICATIONS						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Junction to case, single leg conducting	В		-	-	0.7	
Junction to case, both legs conducting	- R <sub>thJC</sub>		-	-	0.35	°C/W
Case to heatsink	R <sub>thCS</sub>	Flat, greased and surface	-	0.05	-	
Weight			-	30	-	g
Mounting torque			-	1.3	-	Nm





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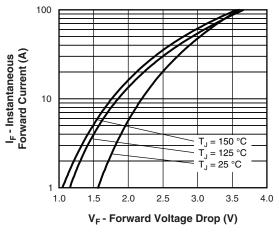


Fig. 1 - Typical Forward Voltage Drop Characteristics

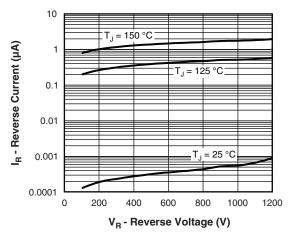


Fig. 2 - Typical Values of Reverse Current vs. Reverse Voltage

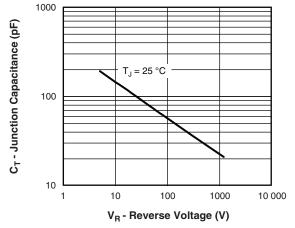


Fig. 3 - Typical Junction Capacitance vs. Reverse Voltage

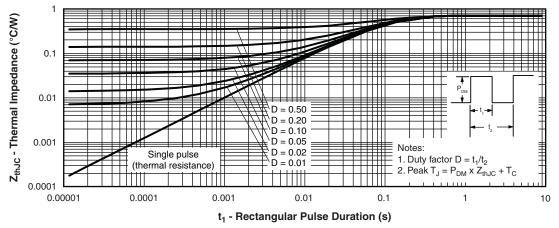


Fig. 4 - Maximum Thermal Impedance Z<sub>thJC</sub> Characteristics

### HFA80FA120P

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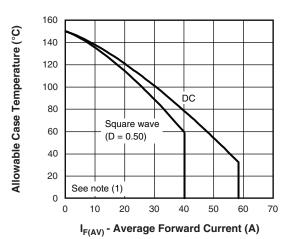


Fig. 5 - Maximum Allowable Case Temperature vs.
Average Forward Current

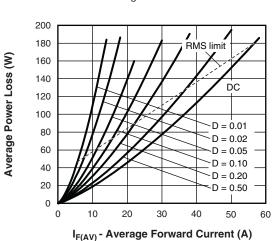


Fig. 6 - Forward Power Loss Characteristics

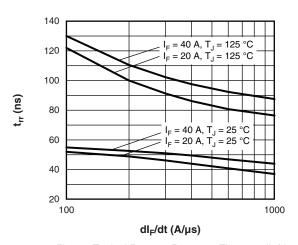


Fig. 7 - Typical Reverse Recovery Time vs.  $dI_F/dt$ 

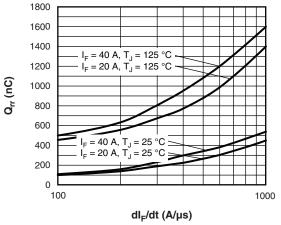


Fig. 8 - Typical Stored Charge vs. dI<sub>F</sub>/dt

#### Note

 $\begin{array}{ll} \text{(1)} & \text{Formula used: } T_C = T_J - (\text{Pd} + \text{Pd}_{\text{REV}}) \times \text{R}_{\text{thJC}}; \\ \text{Pd} = \text{Forward power loss} = \text{I}_{\text{F(AV)}} \times \text{V}_{\text{FM}} \text{ at (I}_{\text{F(AV)}}/\text{D) (see fig. 6)}; \\ \text{Pd}_{\text{REV}} = \text{Inverse power loss} = \text{V}_{\text{R1}} \times \text{I}_{\text{R}} \text{ (1 - D); I}_{\text{R}} \text{ at V}_{\text{R1}} = \text{Rated V}_{\text{R}} \\ \end{array}$ 



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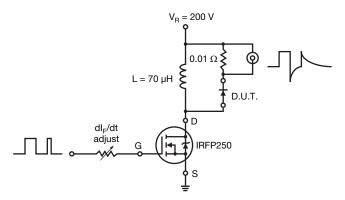
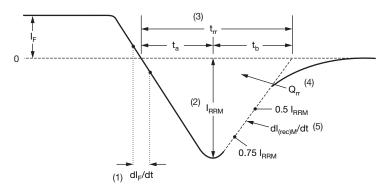


Fig. 9 - Reverse Recovery Parameter Test Circuit



- (1) dl<sub>F</sub>/dt rate of change of current through zero crossing
- (2)  $I_{RRM}$  peak reverse recovery current
- (3)  $t_{\rm rr}$  reverse recovery time measured from zero crossing point of negative going  $I_{\rm F}$  to point where a line passing through 0.75  $I_{\rm RRM}$  and 0.50  $I_{\rm RRM}$  extrapolated to zero current.
- (4)  $\mathbf{Q}_{rr}$  area under curve defined by  $\mathbf{t}_{rr}$  and  $\mathbf{I}_{RRM}$

$$Q_{rr} = \frac{\tau_{rr} \times I_{RRM}}{2}$$

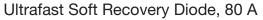
(5)  $dl_{(rec)M}/dt$  - peak rate of change of current during  $t_b$  portion of  $t_{rr}$ 

Fig. 10 - Reverse Recovery Waveform and Definitions

### HFA80FA120P

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### **HEXFRED®**



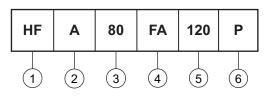


Document Number: 94075

Revision: 22-Jul-10

### **ORDERING INFORMATION TABLE**

Device code



1 - HEXFRED® family

2 - Process designator (A = Electron irradiated)

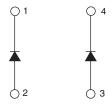
**3** - Average current (80 = 80 A)

- Package outline (FA = SOT-227)

5 - Voltage rating (120 = 1200 V)

6 - P = Lead (Pb)-free

#### **CIRCUIT CONFIGURATION**



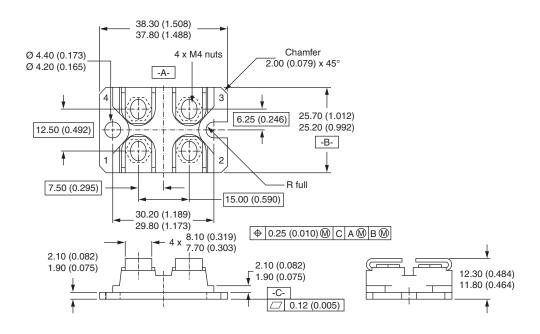
LINKS TO RELATED DOCUMENTS					
Dimensions <u>www.vishay.com/doc?95036</u>					
Packaging information	www.vishay.com/doc?95037				



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## **SOT-227**

### **DIMENSIONS** in millimeters (inches)



#### Notes

- Dimensioning and tolerancing per ANSI Y14.5M-1982
- · Controlling dimension: millimeter

Document Number: 95036 Revision: 28-Aug-07



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Revision: 02-Oct-12 Document Number: 91000